ANALYSIS AND DESIGN OF ANALOG INTEGRATED CIRCUITS

Fourth Edition



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Preface

In the 23 years since the publication of the first edition of this book, the field of analog integrated circuits has developed and matured. The initial groundwork was laid in bipolar technology, followed by a rapid evolution of MOS analog integrated circuits. Furthermore, BiCMOS technology (incorporating both bipolar and CMOS devices on one chip) has emerged as a serious contender to the original technologies. A key issue is that CMOS technologies have become dominant in building digital circuits because CMOS digital circuits are smaller and dissipate less power than their bipolar counterparts. To reduce system cost and power dissipation, analog and digital circuits are now often integrated together, providing a strong economic incentive to use CMOS-compatible analog circuits. As a result, an important question in many applications is whether to use pure CMOS or a BiCMOS technology. Although somewhat more expensive to fabricate, BiCMOS allows the designer to use both bipolar and MOS devices to their best advantage, and also allows innovative combinations of the characteristics of both devices. In addition, BiCMOS can reduce the design time by allowing direct use of many existing cells in realizing a given analog circuit function. On the other hand, the main advantage of pure CMOS is that it offers the lowest overall cost. Twenty years ago, CMOS technologies were only fast enough to support applications at audio frequencies. However, the continuing reduction of the minimum feature size in integrated-circuit (IC) technologies has greatly increased the maximum operating frequencies, and CMOS technologies have become fast enough for many new applications as a result. For example, the required bandwidth in video applications is about 4 MHz, requiring bipolar technologies as recently as 15 years ago. Now, however, CMOS can easily accommodate the required bandwidth for video and is even being used for radio-frequency applications.

In this fourth edition, we have combined the consideration of MOS and bipolar circuits into a unified treatment that also includes MOS-bipolar connections made possible by BiCMOS technology. We have written this edition so that instructors can easily select topics related to only CMOS circuits, only bipolar circuits, or a combination of both. We believe that it has become increasingly important for the analog circuit designer to have a thorough appreciation of the similarities and differences between MOS and bipolar

devices, and to be able to design with either one where this is appropriate.

Since the SPICE computer analysis program is now readily available to virtually all electrical engineering students and professionals, we have included extensive use of SPICE in this edition, particularly as an integral part of many problems. We have used computer analysis as it is most commonly employed in the engineering design process—both as a more accurate check on hand calculations, and also as a tool to examine complex circuit behavior beyond the scope of hand analysis. In the problem sets, we have also included a number of open-ended design problems to expose the reader to real-world situations where a whole range of circuit solutions may be found to satisfy a given performance specification.

This book is intended to be useful both as a text for students and as a reference book for practicing engineers. For class use, each chapter includes many worked problems; the problem sets at the end of each chapter illustrate the practical applications of the material in the text. All the authors have had extensive industrial experience in IC design as well

as in the teaching of courses on this subject, and this experience is reflected in the choice of text material and in the problem sets.

Although this book is concerned largely with the analysis and design of ICs, a considerable amount of material is also included on applications. In practice, these two subjects are closely linked, and a knowledge of both is essential for designers and users of ICs. The latter compose the larger group by far, and we believe that a working knowledge of IC design is a great advantage to an IC user. This is particularly apparent when the user must choose from among a number of competing designs to satisfy a particular need. An understanding of the IC structure is then useful in evaluating the relative desirability of the different designs under extremes of environment or in the presence of variations in supply voltage. In addition, the IC user is in a much better position to interpret a manufacturer's data if he or she has a working knowledge of the internal operation of the integrated circuit.

The contents of this book stem largely from courses on analog integrated circuits given at the University of California at the Berkeley and Davis campuses. The courses are undergraduate electives and first-year graduate courses. The book is structured so that it can be used as the basic text for a sequence of such courses. The more advanced material is found at the end of each chapter or in an appendix so that a first course in analog integrated circuits can omit this material without loss of continuity. An outline of each chapter is given below together with suggestions for material to be covered in such a first course. It is assumed that the course consists of three hours of lecture per week over a 15-week semester and that the students have a working knowledge of Laplace transforms and frequency-domain circuit analysis. It is also assumed that the students have had an introductory course in electronics so that they are familiar with the principles of transistor operation and with the functioning of simple analog circuits. Unless otherwise stated, each chapter requires three to four lecture hours to cover.

Chapter 1 contains a summary of bipolar transistor and MOS transistor device physics. We suggest spending one week on selected topics from this chapter, the choice of topics depending on the background of the students. The material of Chapters 1 and 2 is quite important in IC design because there is significant interaction between circuit and device design, as will be seen in later chapters. A thorough understanding of the influence of device fabrication on device characteristics is essential.

Chapter 2 is concerned with the technology of IC fabrication and is largely descriptive. One lecture on this material should suffice if the students are assigned to read the chapter.

Chapter 3 deals with the characteristics of elementary transistor connections. The material on one-transistor amplifiers should be a review for students at the senior and graduate levels and can be assigned as reading. The section on two-transistor amplifiers can be covered in about three hours, with greatest emphasis on differential pairs. The material on device mismatch effects in differential amplifiers can be covered to the extent that time allows.

In Chapter 4, the important topics of current mirrors and active loads are considered. These configurations are basic building blocks in modern analog IC design, and this material should be covered in full, with the exception of the material on band-gap references and the material in the appendices.

Chapter 5 is concerned with output stages and methods of delivering output power to a load. Integrated-circuit realizations of Class A, Class B, and Class AB output stages are described, as well as methods of output-stage protection. A selection of topics from this chapter should be covered.

Chapter 6 deals with the design of operational amplifiers (op amps). Illustrative examples of dc and ac analysis in both MOS and bipolar op amps are performed in detail, and the limitations of the basic op amps are described. The design of op amps with improved

characteristics in both MOS and bipolar technologies is considered. This key chapter on amplifier design requires at least six hours.

In Chapter 7, the frequency response of amplifiers is considered. The zero-value time-constant technique is introduced for the calculations of the -3-dB frequency of complex circuits. The material of this chapter should be considered in full.

Chapter 8 describes the analysis of feedback circuits. Two different types of analysis are presented: two-port and return-ratio analyses. Either approach should be covered in full with the section on voltage regulators assigned as reading.

Chapter 9 deals with the frequency response and stability of feedback circuits and should be covered up to the section on root locus. Time may not permit a detailed discussion of root locus, but some introduction to this topic can be given.

In a 15-week semester, coverage of the above material leaves about two weeks for Chapters 10, 11, and 12. A selection of topics from these chapters can be chosen as follows. Chapter 10 deals with nonlinear analog circuits, and portions of this chapter up to Section 10.3 could be covered in a first course. Chapter 11 is a comprehensive treatment of noise in integrated circuits, and material up to and including Section 11.4 is suitable. Chapter 12 describes fully differential operational amplifiers and common-mode feedback and may be best suited for a second course.

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Berkeley and Davis, CA, 2001

Paul R. Gray Paul J. Hurst Stephen H. Lewis Robert G. Meyer

Contents

Models for Integrated-Circuit Active Devices 1				1.5.2	of Bipolar and MOS Transistors
1.1	Intro	Introduction 1		1.5.3	Decomposition of Gate-Source Voltage 47
1.2	_	etion Region of a pn Junction 1		1.5.4	Threshold Temperature Dependence 47
	1.2.1	Depletion-Region Capacitance 5 Junction Breakdown 6		1.5.5	1
1.3	Large-Signal Behavior of Bipolar 1.6 Transistors 8			Small-Signal Models of the MOS Transistors 49	
	1.3.1	Large-Signal Models in the Forward-Active Region 9 Effects of Collector Voltage on		1.6.1 1.6.2	Transconductance 50 Intrinsic Gate-Source and Gate-Drain Capacitance 51
		Large-Signal Characteristics in the Forward-Active Region 14	71	1.6.3	
	1.3.3	_		1.6.4 1.6.5	,
	1.3.5	20 Dependence of Transistor Current Gain β_F on Operating Conditions 23		1.6.7	Small-Signal Model 54
1.4	Small	-Signal Models of Bipolar		1.6.8	MOS Transistor Frequency Response 55
	1.4.1	Transistors 26 1.1.1		Short-Channel Effects in MOS Transistors 58	
	1.4.2	Base-Charging Capacitance 28		1.7.1	Velocity Saturation from the
	1.4.3 1.4.4	Input Resistance 29 Output Resistance 29		1.7.2	Horizontal Field 59 Transconductance and Transition Frequency 63
	1.4.5	Basic Small-Signal Model of the Bipolar Transistor 30		1.7.3	Mobility Degradation from the Vertical Field 65
	1.4.6 1.4.7	Collector-Base Resistance 30 Parasitic Elements in the Small-Signal Model 31	1.8	Weak 65	Inversion in MOS Transistors
	1.4.8	Specification of Transistor Frequency Response 34		1.8.1	Drain Current in Weak Inversion 66 Transconductance and Transition
	Metal-	Signal Behavior of Oxide-Semiconductor Effect Transistors 38	1.9	Substr	Frequency in Weak Inversion 68 rate Current Flow in MOS stors 71
	1.5.1	Transfer Characteristics of MOS Devices 38	A.1.1	_	nary of Active-Device